


Search Notes 	Application/Control No. 10724907	Applicant(s)/Patent Under Reexamination SEIVER, JOHN R.
	Examiner Kaplan, Hal I	Art Unit 2836

SEARCHED			
Class	Subclass	Date	Examiner
174	70B	3/5/2007	HK
174	71B	3/5/2007	HK
174	72B	3/5/2007	HK
174	99B	3/5/2007	HK
307	19	3/19/2007	HK
307	20	3/19/2007	HK
307	69	3/19/2007	HK
700	291	3/20/2007	HK

SEARCH NOTES		
Search Notes	Date	Examiner
62/612 (consulted William Doerrier)	9/4/2006	HK
174/70B,71B,72B,99B (consulted Chao Nguyen)	8/31/2006	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	3/5/2007	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	3/6/2007	HK
307/24; 700/286,287 (cursory)	3/20/2007	HK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner